


<b>Search Notes</b>  	<b>Application/Control No.</b>  10576169	<b>Applicant(s)/Patent Under Reexamination</b>  OGASAWARA ET AL.
	<b>Examiner</b>  Tianjie Chen	<b>Art Unit</b>  2627

SEARCHED			
Class	Subclass	Date	Examiner
720	624		
	651		
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369	263	6/16/2008	TJ

SEARCH NOTES			
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